

Search Notes

Application/Control No.

10/614,687

Examiner

Ryan F. Pitaro

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2174

SEARCHED

Class	Subclass	Date	Examiner
715	810	3/25/2007	RFP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	3/25/2007	RFP
Internet	3/25/2007	RFP
IEEE	3/25/2007	RFP
Inventor name search	3/25/2007	RFP